Notice of References Cited Application/Control No. 10/550,103 Examiner ALVIN J. GRANT Applicant(s)/Patent Under Reexamination OKAMURA, TOKUJI Art Unit Page 1 of 3

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Notice of References Cited Application/Control No. 10/550,103 Examiner ALVIN J. GRANT Applicant(s)/Patent Under Reexamination OKAMURA, TOKUJI Art Unit Page 2 of 3

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